

DESCRIPTION

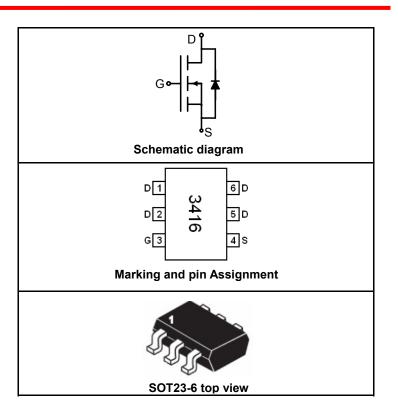
The SSF3416 uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$ and low gate charge .This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

- $V_{DS} = 30V, I_D = 9A$ $R_{DS(ON)} < 30m\Omega @ V_{GS} = 4.5V$ $R_{DS(ON)} < 18.5m\Omega @ V_{GS} = 10V$
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

Application

- ●PWM applications
- Load switch
- Power management



PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
3416	SSF3416	SOT23-6	Ø180mm	8mm	3000 units

ABSOLUTE MAXIMUM RATINGS(TA=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	VDS	30	V	
Gate-Source Voltage	V _G S	±20	V	
	I _D (25℃)	9	A	
rain Current-Continuous@ Current-Pulsed (Note 1)	I _D (70°C)	7		
	I _{DM}	40	А	
Maximum Power Dissipation	P _D	2.5	W	
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}\!\mathbb{C}$	

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{ heta JA}$	62.5	°C/W
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ELECTRICAL CHARACTERISTICS (TA=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	30			V

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Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V,V _{GS} =0V			1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V			±100	nA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	1	1.9	3	V
Prain-Source On-State Resistance	В	V _{GS} =4.5V, I _D =7A		21	30	mΩ
	R _{DS(ON)}	V _{GS} =10V, I _D =9A		16	18.5	mΩ
Forward Transconductance	g FS	V _{DS} =15V,I _D =9A		10		S
DYNAMIC CHARACTERISTICS (Note4)						
Input Capacitance	C _{lss}	V _{DS} =15V,V _{GS} =0V, F=1.0MHz		600		PF
Output Capacitance	Coss			75		PF
Reverse Transfer Capacitance	C _{rss}]		45		PF
SWITCHING CHARACTERISTICS (Note 4)						
Turn-on Delay Time	t _{d(on)}			4		nS
Turn-on Rise Time	tr	V_{DS} =15V, V_{GS} =10V, R_{GEN} =6 Ω		12		nS
Turn-Off Delay Time	$t_{d(off)}$	I _D =1A		22		nS
Turn-Off Fall Time	t _f			4		nS
Total Gate Charge	Qg			12		nC
Gate-Source Charge	Q _{gs}	V _{DS} =15V,I _D =9A,V _{GS} =10V		1.2		nC
Gate-Drain Charge	Q_{gd}			3.8		nC
Body Diode Reverse Recovery Time	Trr	L _0A _dl/dt_400A/::-		13		nS
Body Diode Reverse Recovery Charge	Qrr	- I _F =9A, dI/dt=100A/μs -		7		nC
DRAIN-SOURCE DIODE CHARACTERISTIC	cs	-				
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =3A		0.7	1.2	V
	L			·	L	L

NOTES:

- Repetitive Rating: Pulse width limited by maximum junction temperature.
 Surface Mounted on 1in² FR4 Board, t ≤ 10 sec.
 Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.

- 4. Guaranteed by design, not subject to production testing.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

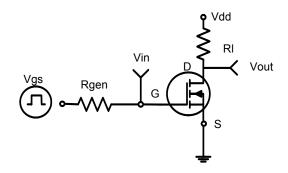


Figure 1:Switching Test Circuit

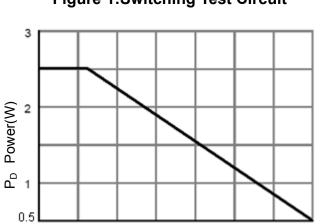


Figure 3 Power Dissipation

T_J-Junction Temperature(°C)

80

100

120

60

40

0

20

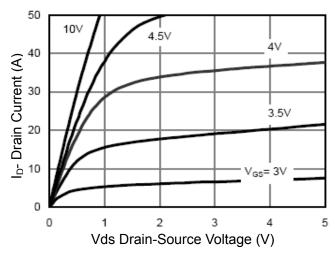


Figure 5 Output CHARACTERISTICS

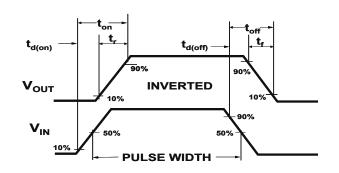


Figure 2:Switching Waveforms

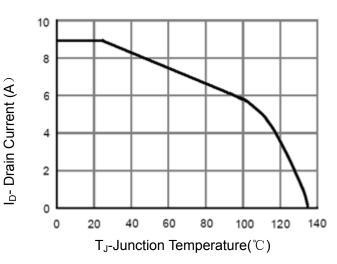


Figure 4 Drain Current

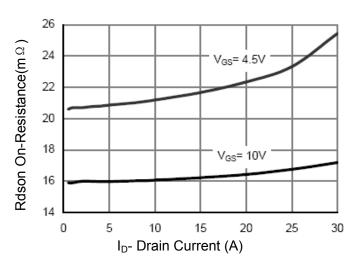


Figure 6 Drain-Source On-Resistance



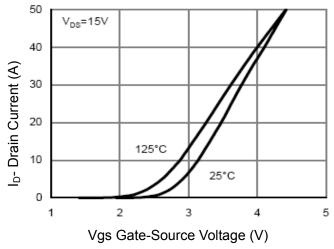


Figure 7 Transfer Characteristics

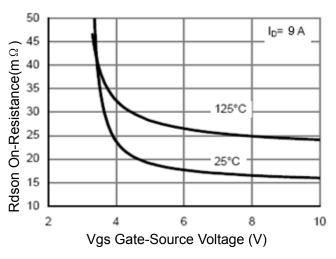


Figure 9 Rdson vs Vgs

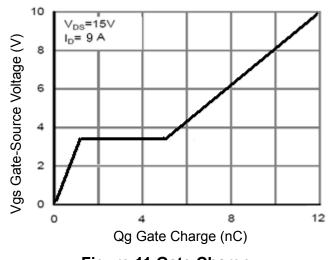


Figure 11 Gate Charge

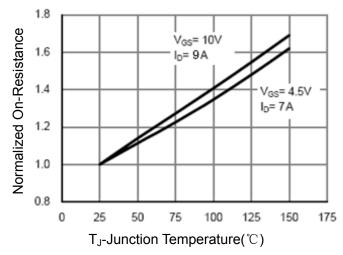


Figure 8 Drain-Source On-Resistance

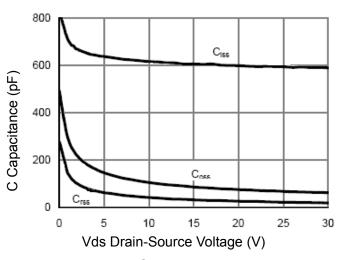


Figure 10 Capacitance vs Vds

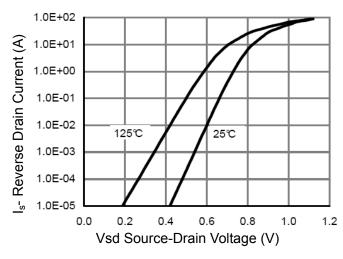


Figure 12 Source- Drain Diode Forward



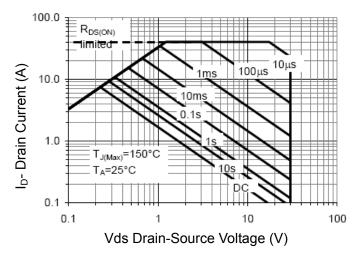
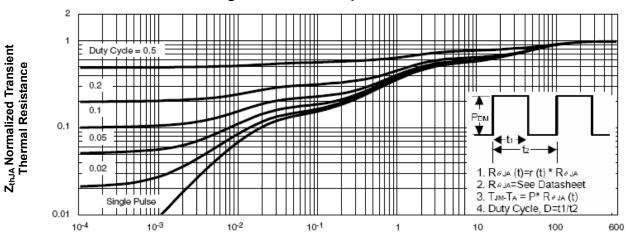


Figure 13 Safe Operation Area

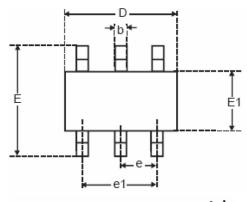


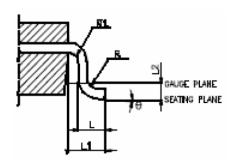
Square Wave Pluse Duration(sec)
Figure 14 Normalized Maximum Transient Thermal Impedance

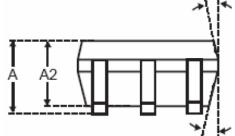


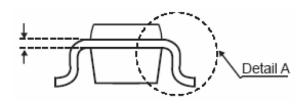
SOT23-6 PACKAGE INFORMATION











eza mor e	MILLMETERS				
SYMBOLS	MIN.	NOM.	MAX.		
A			1.45		
A1			0.15		
A2	0.90	1.15	1.30		
ь	0.30		0.50		
с	0.08		0.22		
D	2.90 BSC.				
E	2.80 BSC.				
E1	1.60 BSC.				
e	0.95 BSC.				
e1	1.90 BSC.				
L	0.30	0.60			
L1	0.60 REF				
L2	0.25 BSC.				
R	0.10				
R1	0.10		0.25		
θ	0.	4	8.		
θ 1	5.	10	15		

NOTES:

- All dimensions are in millimeters.
 Dimensions are inclusive of plating
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.
- 4. Dimension L is measured in gauge plane.
- $5. \ Controlling \ dimension \ is \ millimeter, \ converted \ inch \ dimensions \ are \ not \ necessarily \ exact.$



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